



<b>Form 1449 (Modified)</b> <b>Information Disclosure Statement By Applicant</b> (Use Several Sheets if Necessary)	Attorney Docket No: U.S. LAM2P413 10/607,612 Applicant: DEL PUPPO et al. Filing Date: Group: June 27, 2003 1765
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**U.S. Patent Documents**

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class
BT	A	6,127,278	10/3/00	Wang et al.	438	719
BT	B	6,403,432	6/11/02	Yu et al.	438	296
BT	C	6,491,835	12/10/02	Kumar et al.	216	51
	D					
	E					
	F					
	G					
	H					

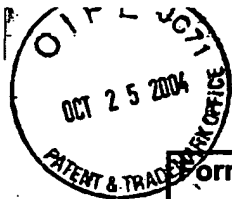
**Foreign Patent or Published Foreign Patent Application**

Examiner Initial	No.	Document No.	Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	I							
	J							
	K							
	L							
	M							

**Other Documents**

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	N	
Examiner	Date Considered	
Binh Tran	7/11/05	

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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### U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class
BT	A	6,283,131	9/4/01	Chen et al.	134	1.2
	B					
	C					
	D					
	E					
	F					
	G					
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